Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/083,510	NAKAYAMA ET AL.
Examiner	Art Unit
Yixing Qin	2625

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
1.18	12/6/2006	YQ		
	Subclass	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Performed subclass and text searching in relevant areas	12/6/2006	YQ	